

<b>Notice of References Cited</b>	Application/Control No. 10/661,204		Applicant(s)/Patent Under Reexamination LAIL ET AL.	
	Examiner Hae M Hyeon		Art Unit 2839	Page 1 of 1

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	N	GB 2189071 A	10-1987	United Kingdom	MARSH et al.	H01B 07/22
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